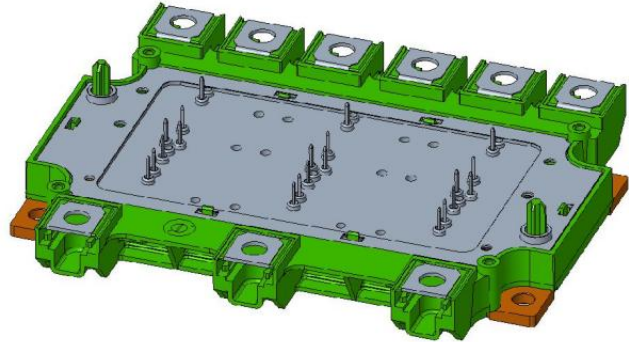


HP1-DC6i IGBT Power Module

$V_{CES} = 750V$, $I_C = 600A$, $V_{CE(sat)} = 1.31V$

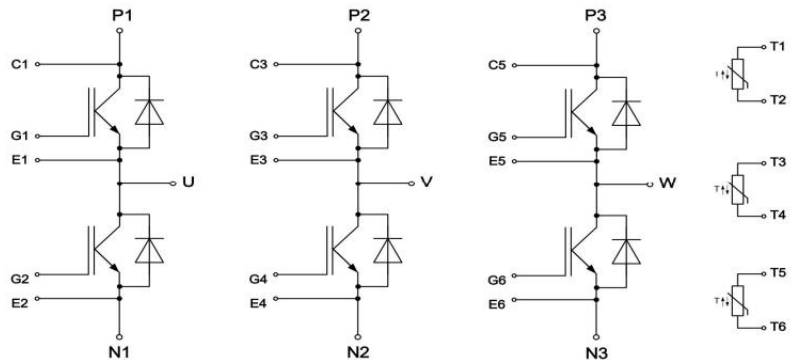
Features

- Low Switching Losses
- Low V_{CEsat}
- 2.5kV AC 1min Insulation
- Blocking voltage 750V
- Low Q_g and Cr_{ss}
- Low Inductive Design
- High Power Density
- Direct Cooled Base Plate with Ribbon Bonds
- High Creepage and Clearance Distance
- Integrated NTC temperature sensor



Applications

- Hybrid Electrical Vehicles (H)EV
- Commercial Agriculture Vehicles
- Motor Drives



IGBT, Inverter Maximum Ratings

Parameter	Symbol	Test Condition	Values	Units
Collector-emitter voltage	V_{CES}	$T_{vj} = 25^\circ C$, $V_{GE} = 0V$	750	V
Implemented collector current	I_{CN}		600	A
Continuous DC collector current	$I_{C\ nom}$	$T_F = 80^\circ C$, $T_{vj\ max} = 175^\circ C$	350 ¹⁾	A
Repetitive peak collector current	I_{CRM}	$t_p = 1ms$, $T_{vj} = 25^\circ C$	1200	A
Gate-emitter peak voltage	V_{GES}	$T_{vj} = 25^\circ C$	± 30	V
SC data	I_{SC}	$V_{GE} \leq 15V$, $V_{CC} = 400V$, $t_p \leq 5\mu s$, $V_{CEmax} = V_{CES} - L_s \cdot di/dt$, $T_{vj} = 150^\circ C$	3750	A
Total power dissipation	P_{tot}	$T_F = 75^\circ C$, $T_{vj\ max} = 175^\circ C$	625 ¹⁾	W

1) Verified by characterization / design not by test.

Characteristics Values

Parameter	Symbol	Test Condition	Values			Units
			Min.	Typ.	Max.	
Collector-emitter saturation voltage	$V_{CE\ sat}$	$I_C = 350A$, $V_{GE} = 15V$, $T_{vj} = 25^\circ C$		1.31	1.55	V
		$I_C = 350A$, $V_{GE} = 15V$, $T_{vj} = 150^\circ C$		1.35	1.61	V
		$I_C = 350A$, $V_{GE} = 15V$, $T_{vj} = 175^\circ C$		1.37	1.66	V

Gate-emitter threshold voltage	V_{GEth}	$V_{CE}=V_{GE}, I_C=6.4mA$	$T_{vj}=25^{\circ}C$	5.9	6.1	6.3	V
			$T_{vj}=175^{\circ}C$		3.9		
Gate charge	Q_G	$V_{GE}=-8V...+15V$			3.5		μC
Integrated gate resistor	R_G	$T_{vj}=25^{\circ}C$			1		Ω
Input capacitance	C_{ies}	$T_{vj}=25^{\circ}C, f=1MHz, V_{GE}=0V, V_{CE}=50V$			28		nF
Output capacitance	C_{oes}	$T_{vj}=25^{\circ}C, f=1MHz, V_{GE}=0V, V_{CE}=50V$			0.65		nF
Reverse transfer capacitance	C_{res}	$T_{vj}=25^{\circ}C, f=1MHz, V_{GE}=0V, V_{CE}=50V$			0.18		nF
Collector-emitter cut-off current	I_{CES}	$V_{CE}=750V, V_{GE}=0V$	$T_{vj}=25^{\circ}C$			0.85	mA
			$T_{vj}=175^{\circ}C$		4		
Gate-emitter leakage current	I_{GES}	$V_{CE}=0V, V_{GE}=20V, T_{vj}=25^{\circ}C$				380	nA
Turn-on delay time, inductive load	t_{don}	$I_C=350A, V_{CE}=400V, V_{GE}=-8V/+15V, R_{Gon}=R_{Goff}=5\Omega$	$T_{vj}=25^{\circ}C$		315		ns
			$T_{vj}=150^{\circ}C$		330		ns
			$T_{vj}=175^{\circ}C$		340		ns
Rise time, inductive load	t_r		$T_{vj}=25^{\circ}C$		75		ns
			$T_{vj}=150^{\circ}C$		90		ns
			$T_{vj}=175^{\circ}C$		95		ns
Turn-off delay time, inductive load	$T_{d(off)}$		$T_{vj}=25^{\circ}C$		785		ns
			$T_{vj}=150^{\circ}C$		885		ns
			$T_{vj}=175^{\circ}C$		935		ns
Fall time, inductive load	t_f	$T_{vj}=25^{\circ}C$		75		ns	
		$T_{vj}=150^{\circ}C$		75		ns	
		$T_{vj}=175^{\circ}C$		80		ns	
Turn-on energy loss per pulse	E_{on}	$T_{vj}=25^{\circ}C$		8.2		mJ	
		$T_{vj}=150^{\circ}C$		16		mJ	
		$T_{vj}=175^{\circ}C$		17.5		mJ	
Turn-off energy loss per pulse	E_{off}	$T_{vj}=25^{\circ}C$		16.5		mJ	
		$T_{vj}=150^{\circ}C$		25.4		mJ	
		$T_{vj}=175^{\circ}C$		26.6		mJ	
Thermal resistance, junction to cooling fluid	R_{thJF}	Per IGBT, $\Delta V/\Delta t=10dm^3/min, T_F=75^{\circ}C$			0.16		K/W

Diode, Inverter Maximum Ratings

Parameter	Symbol	Test Condition	Values	Units
Repetitive peak reverse voltage	V_{RRM}	$T_{vj}=25^{\circ}C$	750	V
Implemented forward current	I_{FN}		600	A

Continuous forward current	I_F		350 ⁽¹⁾	A
Maximum repetitive forward current	I_{FRM}	$t_p=1\text{ms}$	1200	A
I_{2t} -value	ρ_t	$V_R=0\text{V}, t_p=10\text{ms}, T_{vj}=150^\circ\text{C}$	14500	A ² s
		$V_R=0\text{V}, t_p=10\text{ms}, T_{vj}=175^\circ\text{C}$	12500	

Characteristics Values

Parameter	Symbol	Test Condition	Values			Units
			Min.	Typ.	Max.	
Forward voltage	V_F	$I_F=350\text{A}, V_{GE}=0\text{V}$	$T_{vj}=25^\circ\text{C}$	1.47		V
			$T_{vj}=150^\circ\text{C}$	1.37		V
			$T_{vj}=175^\circ\text{C}$	1.33		V
Peak reverse recovery current	I_{RM}		$T_{vj}=25^\circ\text{C}$	207		A
			$T_{vj}=150^\circ\text{C}$	317		A
			$T_{vj}=175^\circ\text{C}$	337		A
Recovered charge	Q_r	$I_F=350\text{A}, V_R=400\text{V}, V_{GE}=-8\text{V}, diF/dt=3950\text{A}/\mu\text{s} (T_{vj} 150^\circ\text{C})$	$T_{vj}=25^\circ\text{C}$	24.3		μC
			$T_{vj}=150^\circ\text{C}$	47.9		μC
			$T_{vj}=175^\circ\text{C}$	55.8		μC
Reverse recovery energy	E_{rec}		$T_{vj}=25^\circ\text{C}$	2.1		mJ
			$T_{vj}=150^\circ\text{C}$	5.5		mJ
			$T_{vj}=175^\circ\text{C}$	7.2		mJ
Thermal resistance, junction to cooling fluid	R_{thJF}	Per diode, $\Delta V/\Delta t=10\text{dm}^3/\text{min}, T_F=75^\circ\text{C}$			0.25	K/W

NTC Thermistor Characteristics Values

Parameter	Symbol	Test Condition	Values			Units
			Min.	Typ.	Max.	
Rated resistance	R_{25}	$T_C=25^\circ\text{C}$		5.0		K Ω
Deviation of R100	$\Delta R/R$	$T_C=100^\circ\text{C}, R_{100}=493\Omega$	-3		3	%
Power dissipation	P_{25}	$T_C=25^\circ\text{C}$			60	mW
B-value	$B_{25/50}$	$R_2=R_{25}\exp[B_{25/50}(1/T_2-1/(298.15\text{K}))]$		3375		K
B-value	$B_{25/80}$	$R_2=R_{25}\exp[B_{25/80}(1/T_2-1/(298.15\text{K}))]$		3411		K
B-value	$B_{25/100}$	$R_2=R_{25}\exp[B_{25/100}(1/T_2-1/(298.15\text{K}))]$		3433		K

Characteristics Values(Module)

Parameter	Symbol	Test Condition	Values			Units
			Min.	Typ.	Max.	
Maximum junction temperature	$T_{vj\text{max}}$				175	$^\circ\text{C}$

Temperature under switching conditions	$T_{vj\ op}$		-40		175	°C
Storage temperature	T_{stg}		-40		150	°C
Stray inductance module	L_{sCE}			21		nH
Module lead resistance, terminals-chip	$R_{CC} + EE$	$T_{vj}=25^{\circ}C$, per switch		0.9		mΩ
Isolation test voltage	V_{isol}	RMS, f=50Hz, t= 1min		2.5		kV
Creepage distance	ds	Terminal to heat sink		18.2		mm
		Terminal to terminal		8.2		mm
Clearance distance in air	da	Terminal to heat sink		18.2		mm
		Terminal to terminal		5.9		mm
Comparative tracking index	CTI		>200			
Mounting torque for module mounting	M1	Screw M5 base plate to heat sink	1.8	2.0	2.2	N.m
	M2	Screw M3 EJOT Delta PCB to frame	0.45	0.50	0.55	
Mounting torque for module mounting	M3	Screw M6	3		6	
Internal isolation	-	Basic insulation	Al2O3			-
Material of module base plate	-		Cu+Ni			-
Dimensions	$L \times W \times H$		140x112.6x23.15			mm
Weight	G		610			g

Typical Characteristics

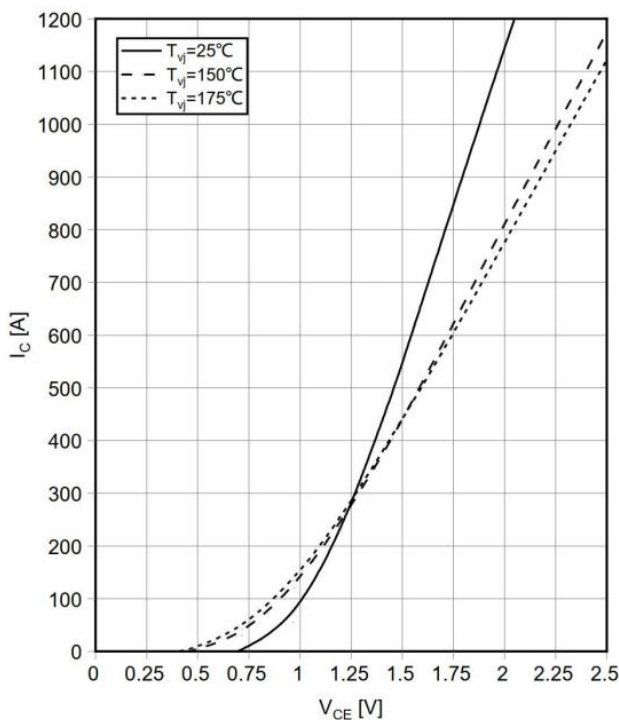


Fig 1. Output characteristic IGBT, Inverter (typical)
 $I_c = f(V_{CE})$, $V_{GE} = 15V$

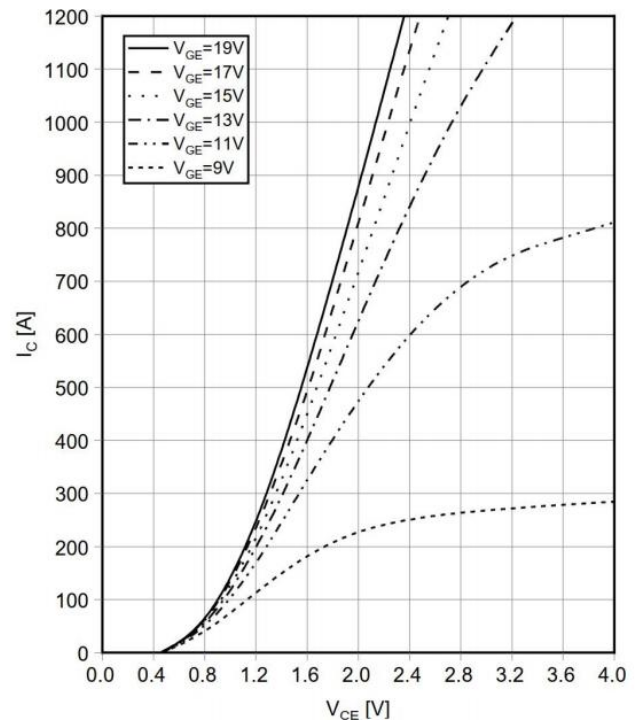


Fig 2. Output characteristic IGBT, Inverter (typical)
 $I_c = f(V_{CE})$, $T_{vj} = 150^{\circ}C$

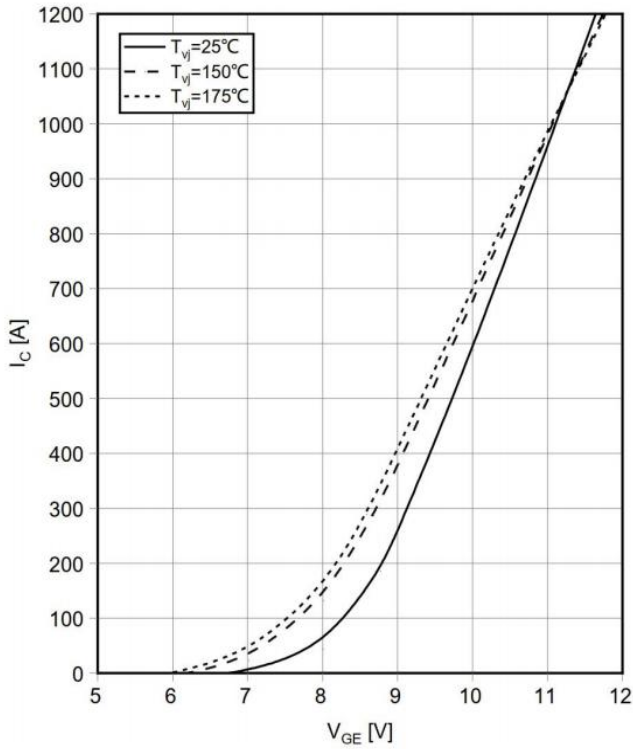


Fig 3. Transfer characteristic IGBT, Inverter(typical)
 $I_C=f(V_{GE})$, $V_{CE}=20V$

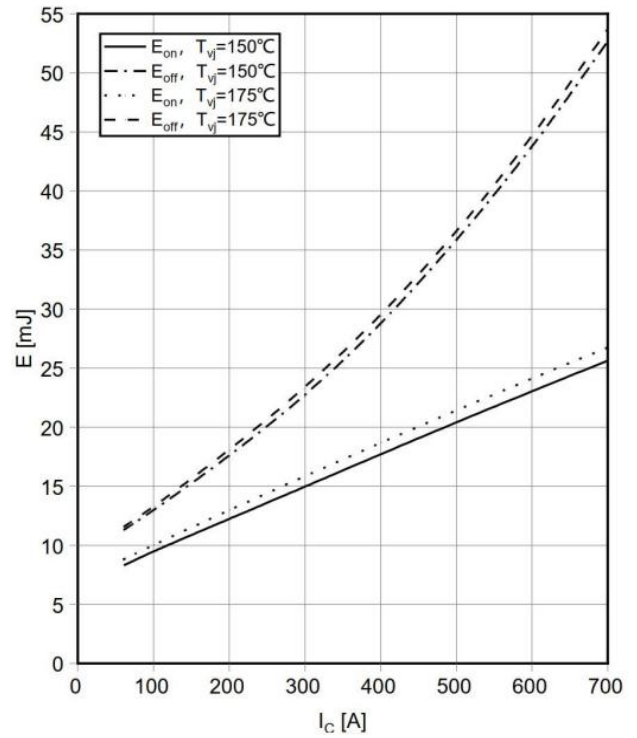


Fig 4. Switching losses IGBT, Inverter(typical)
 $E_{on}=f(I_C)$, $E_{off}=f(I_C)$, $V_{GE}=-8/+15V$, $R_{Gon}=R_{Goff}=5\Omega$,
 $V_{CE}=400V$

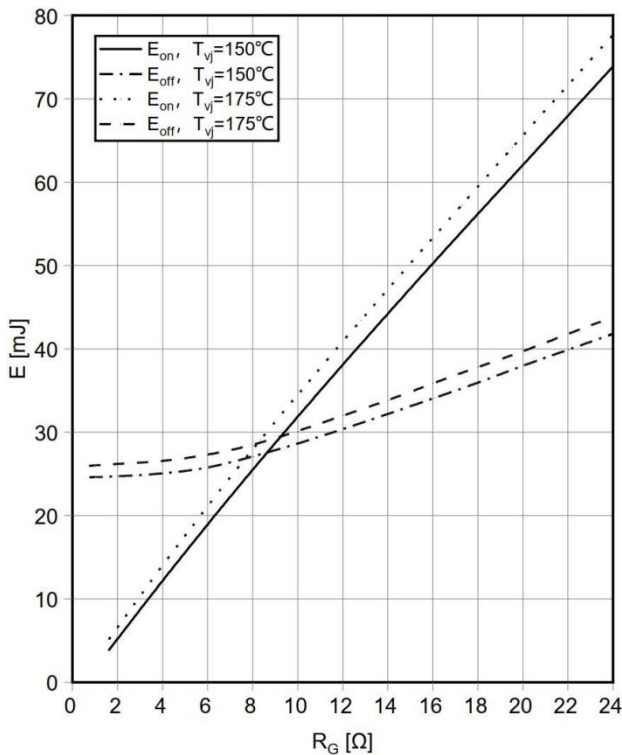


Fig 5. Switching losses IGBT, Inverter(typical)
 $E_{on}=f(R_G)$, $E_{off}=f(R_G)$, $V_{GE}=-8/+15V$, $I_C=350A$,
 $V_{CE}=400V$

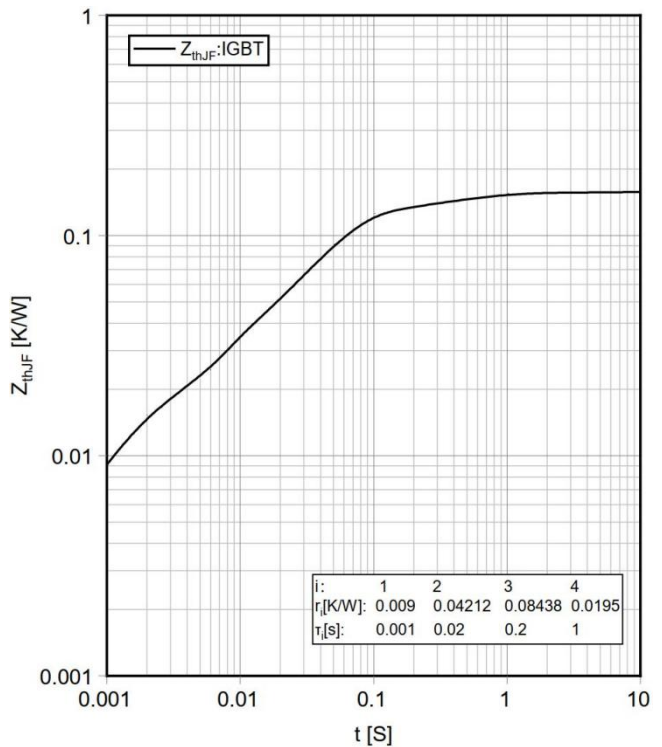


Fig 6. Transient thermal impedance IGBT, Inverter
 $Z_{thJF}=f(t)$

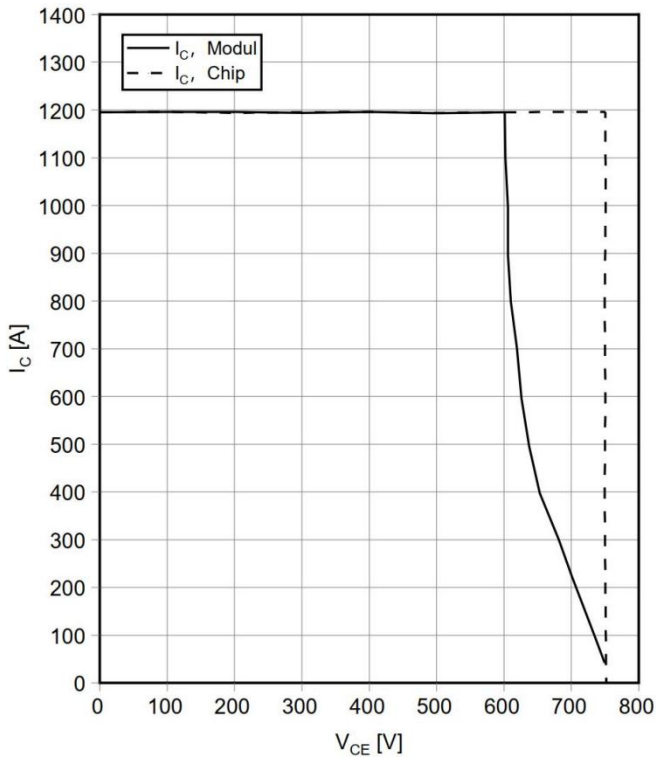


Fig 7.Reverse bias safe operating area IGBT, Inverter(RBSOA) $I_C=f(V_{CE})$, $V_{GE}=-8V/+15V$, $R_{Goff}=5\Omega$, $T_{vj}=175^\circ\text{C}$

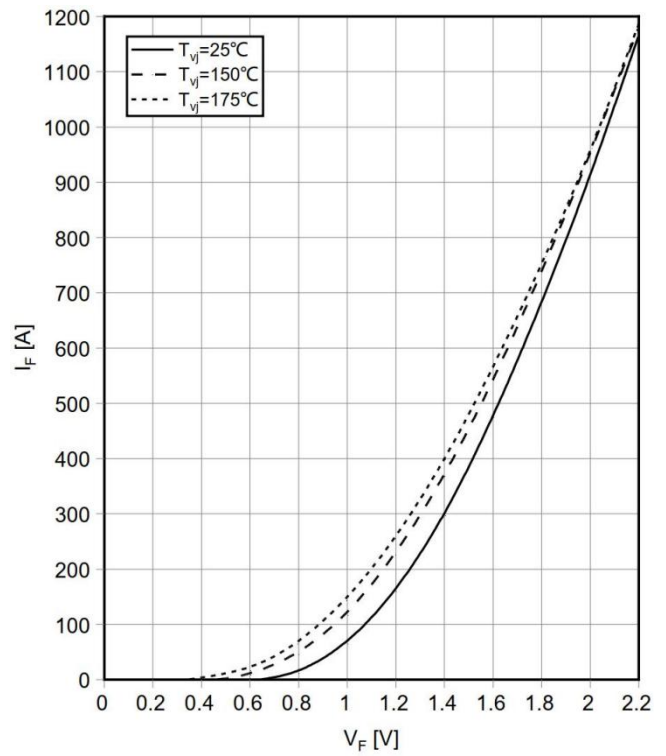


Fig 8.Forward characteristic of Diode, Inverter(typical) $I_F=f(V_F)$

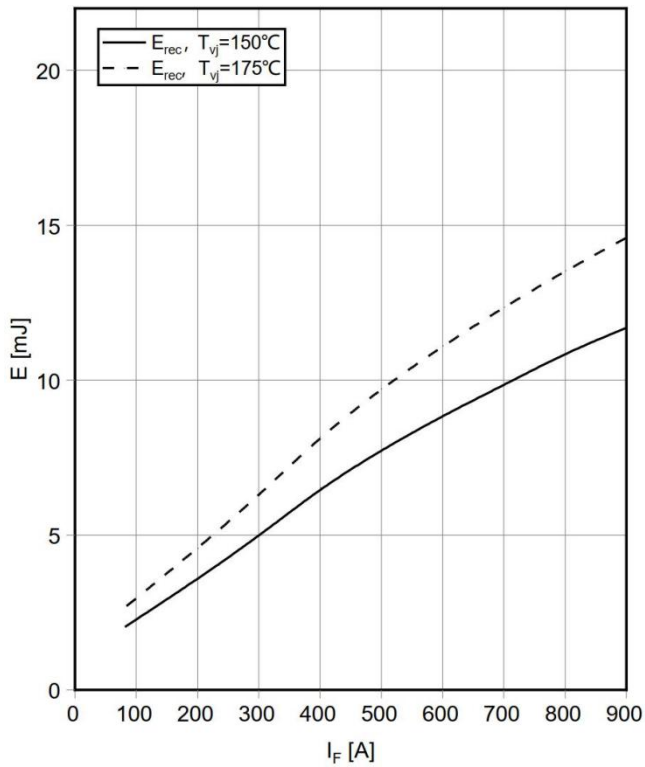


Fig 9.Switching losses Diode, Inverter(typical) $E_{rec}=f(I_F)$, $R_{Gon}=5\Omega$, $V_{CE}=400V$

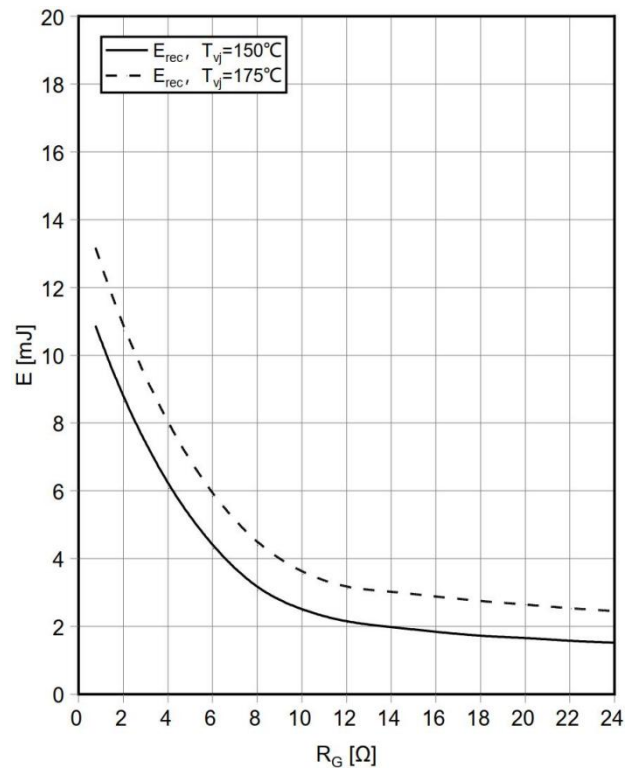


Fig 10.Switching losses Diode, Inverter(typical) $E_{rec}=f(I_F)$, $I_F=350A$, $V_{CE}=400V$

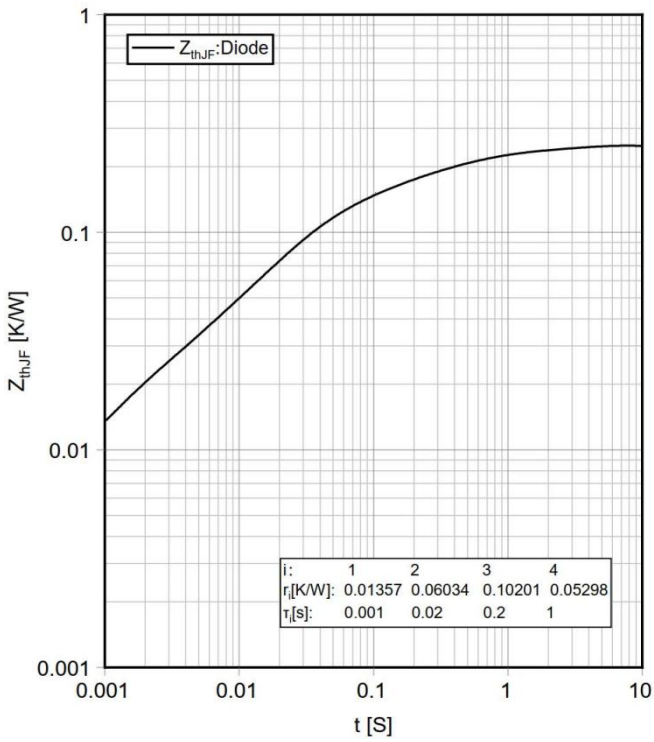


Fig 11. Transient thermal impedance Diode, Inverter $Z_{thJF}=f(t)$

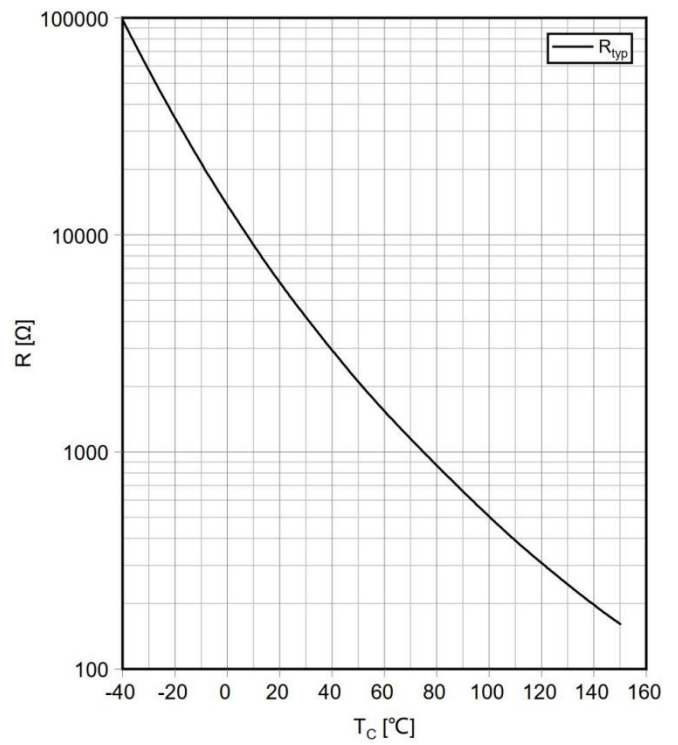
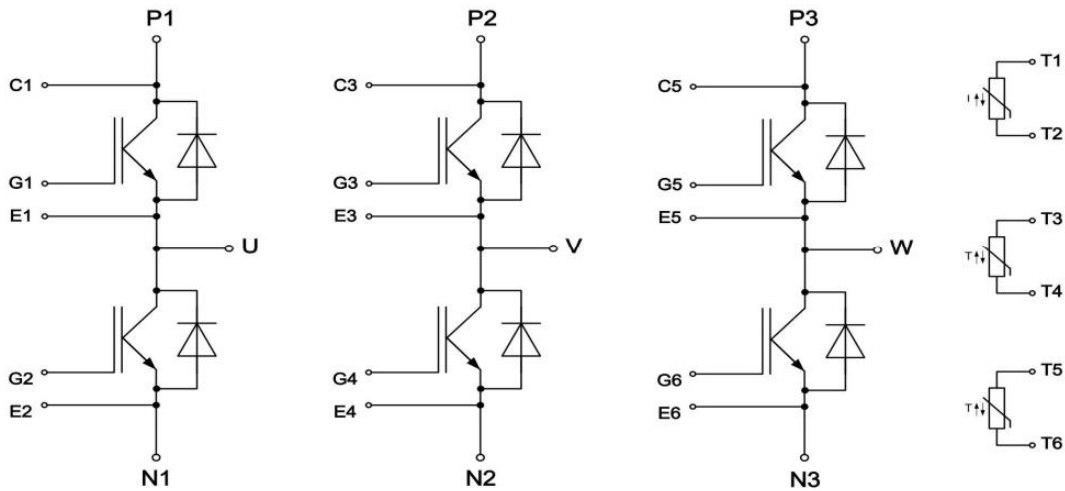
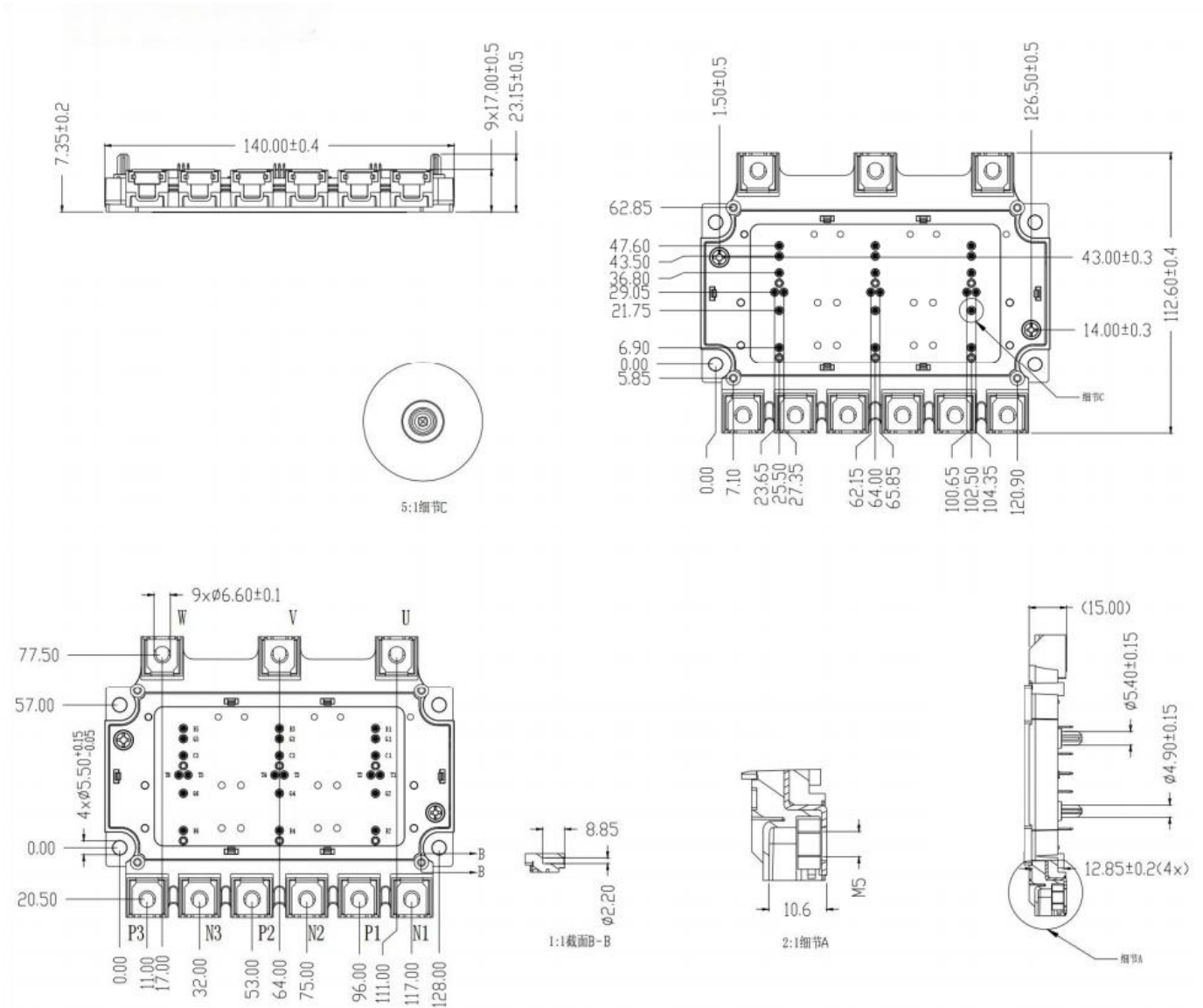


Fig 12. NTC Thermistor temperature characteristic (typical), $R=f(\tau)$

Circuit Diagram



Package Outlines(Unit: mm)



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